

<b>Notice of References Cited</b>	Application/Control No. 09/622,199	Applicant(s)/Patent Under Reexamination SCHWARTZ ET AL.	
	Examiner D. Margaret Seaman	Art Unit 1625	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
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	C	US-			
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**FOREIGN PATENT DOCUMENTS**

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**NON-PATENT DOCUMENTS**

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	U	Yamada, Chemical Abstracts 125:345266, abstract of JP 08227828, 1996.
	V	Fenton, CA 125:10758, abstract of Tetrahedron, vol 52(16), pp 5913-28, 1996.
	W	Psiorz, CA 116:41309, abstract of EP 450429, 1991.
	X	Witek, CA 99:210420, abstract of DE 2810066, 1978.

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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